

Thermal Conductivity and Interface Thermal Conductance of Phase Change Materials

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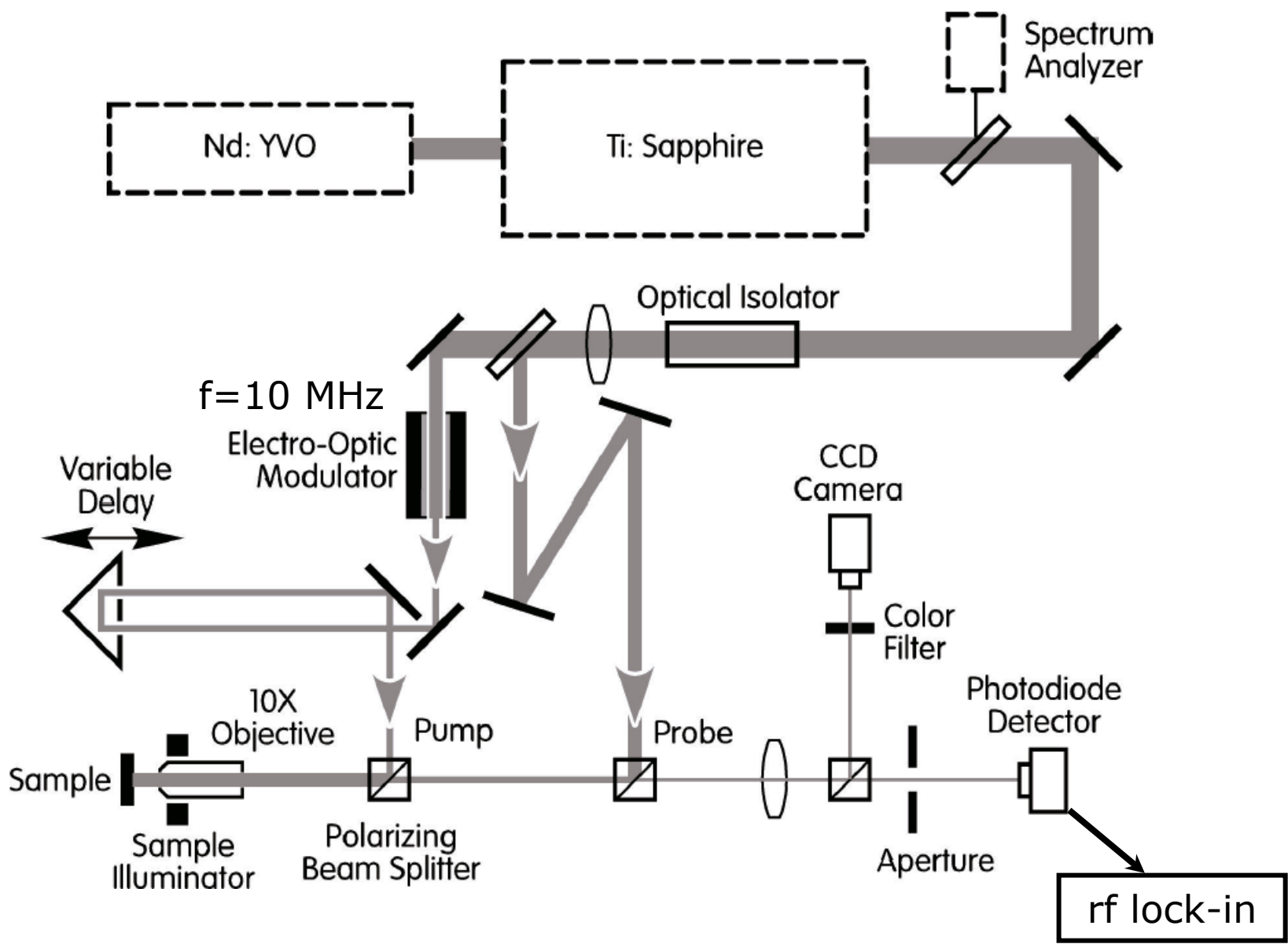
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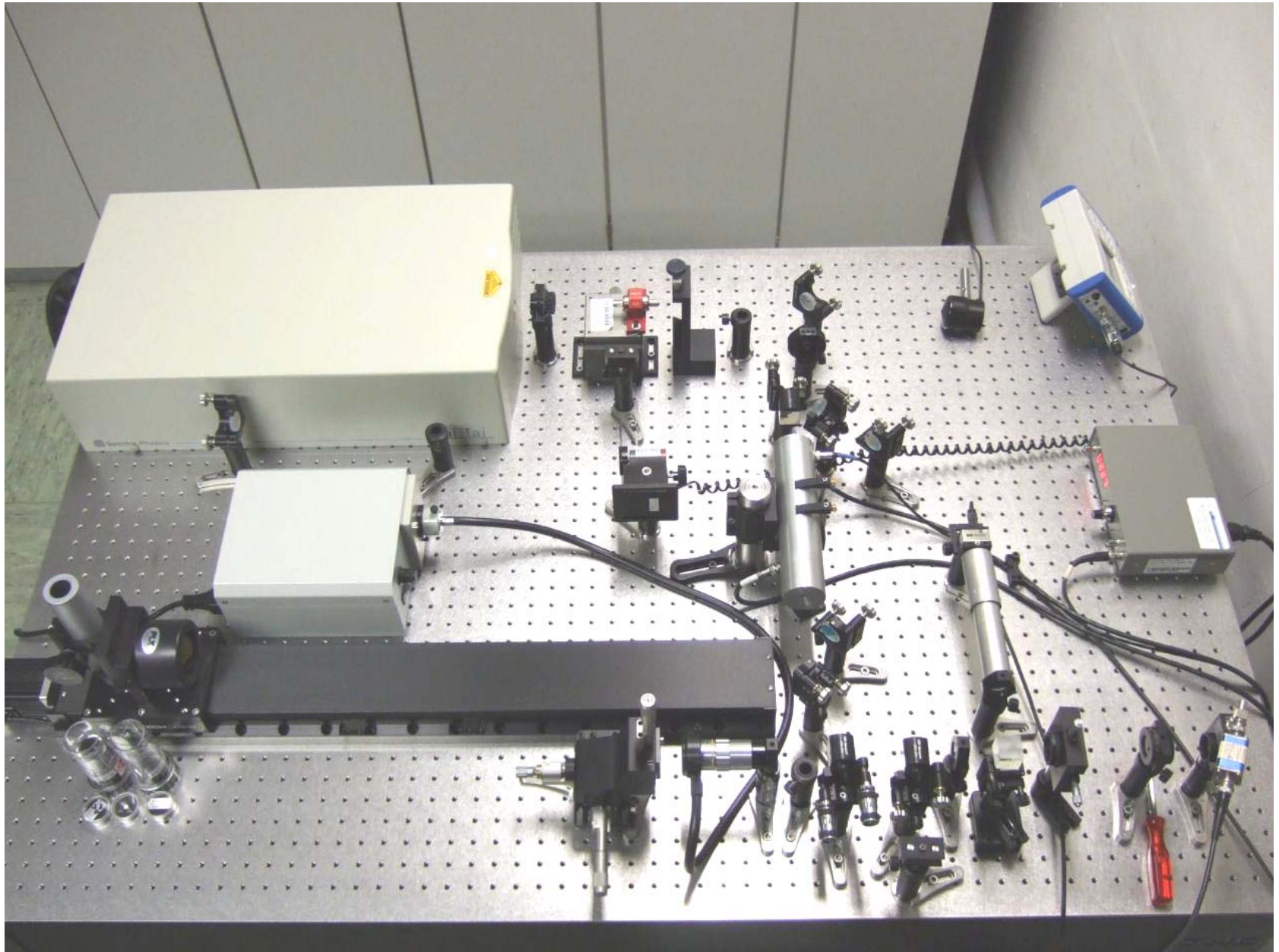
Outline

- **Measurement:** Modulated time-domain thermoreflectance (TDTR)
- **Thermal conductivity:** Phase change materials and the minimum thermal conductivity.
- **Thermal conductance of interfaces with electrodes:** Interfaces between highly dissimilar materials and anharmonic phonon transport.
- **Controlling thermal conductance with thin interfacial layers:** C₆₀ films (demonstrated); disordered layered crystals WSe₂ (proposed).

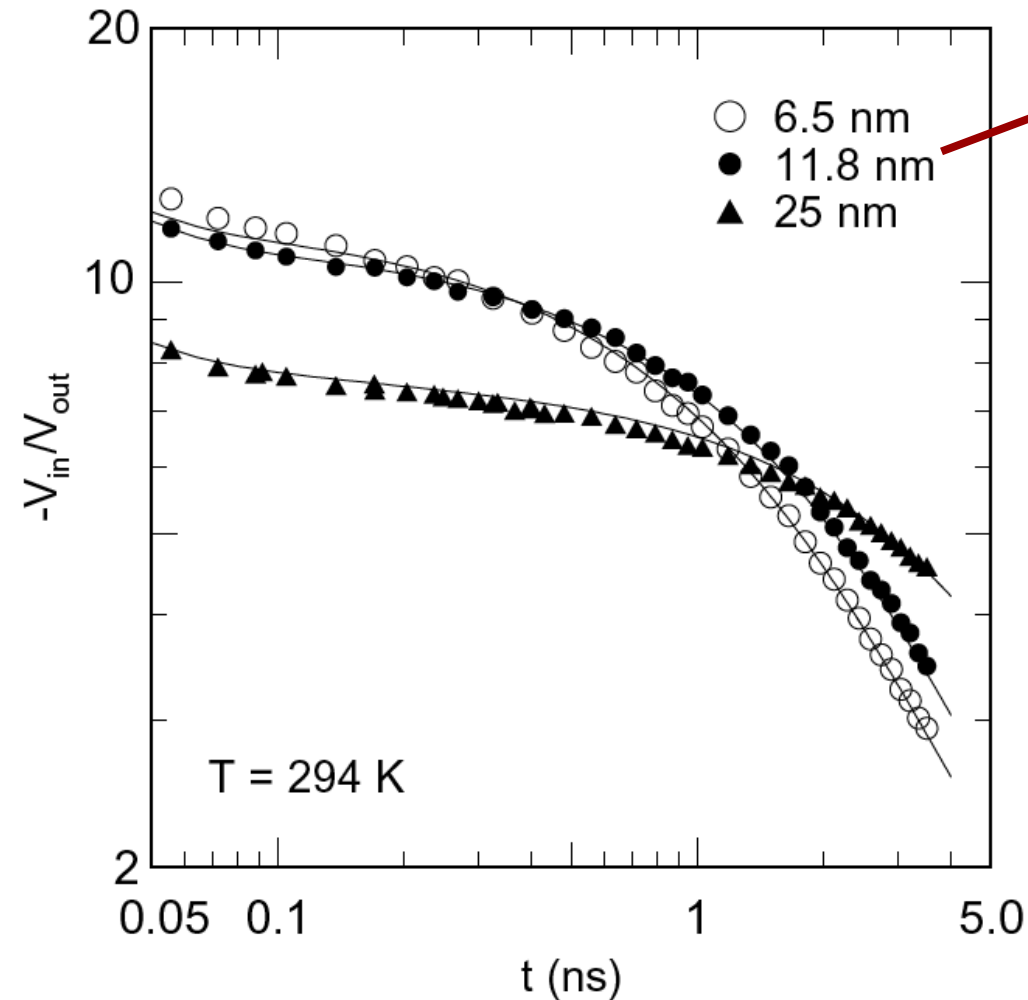
Modulated pump-probe apparatus



IPM system built January 7-8, 2008

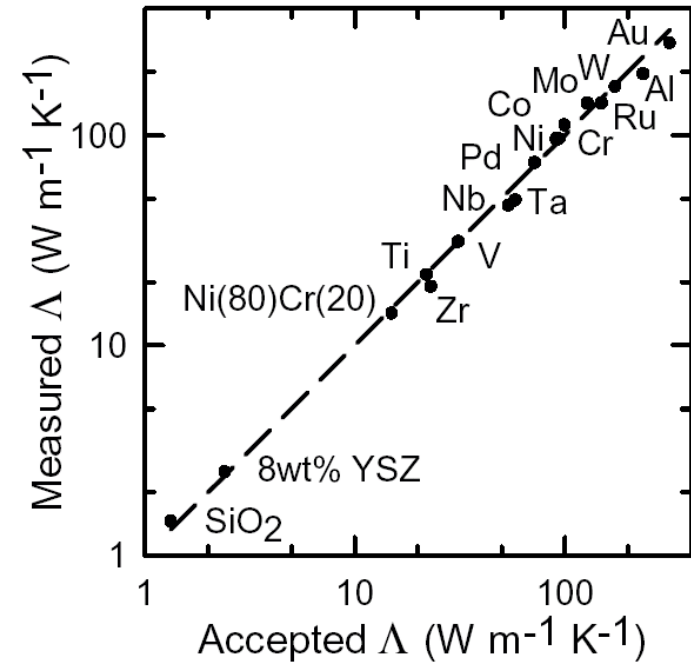
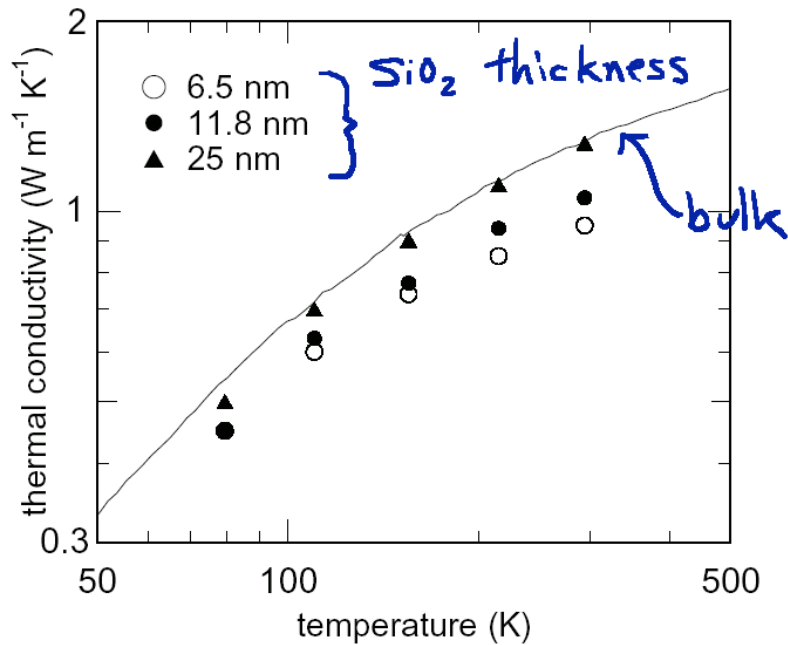


Time-domain Thermoreflectance (TDTR) data for TiN/SiO₂/Si



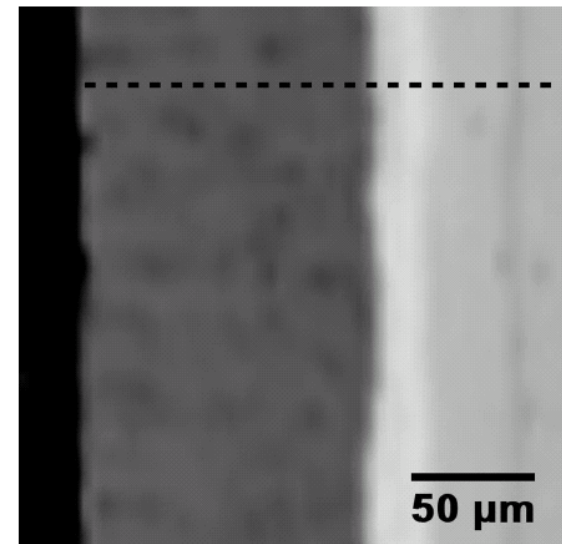
- reflectivity of a metal depends on temperature
- one free parameter: the “effective” thermal conductivity of the thermally grown SiO₂ layer (interfaces not modeled separately)

Flexible, convenient, and accurate technique...



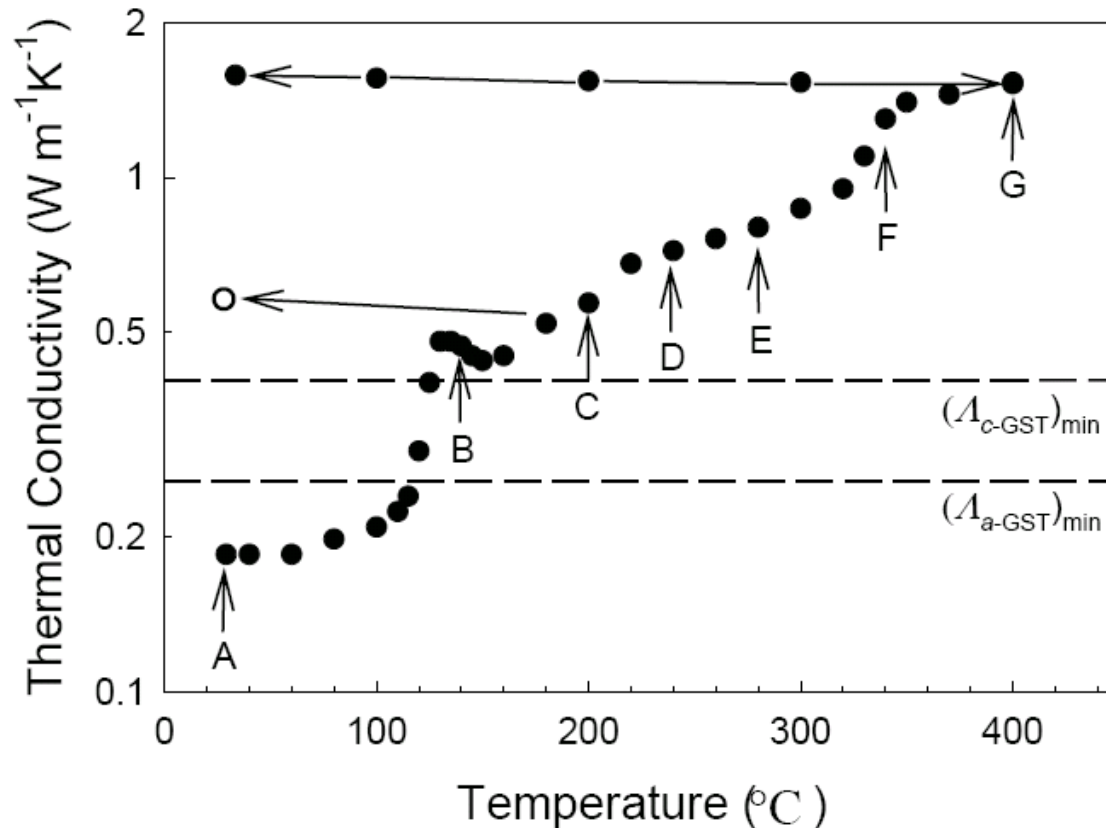
- ...with 3 micron resolution

thermal conductivity map of cross-section of thermal barrier coating, with J.-C. Zhao (GE)



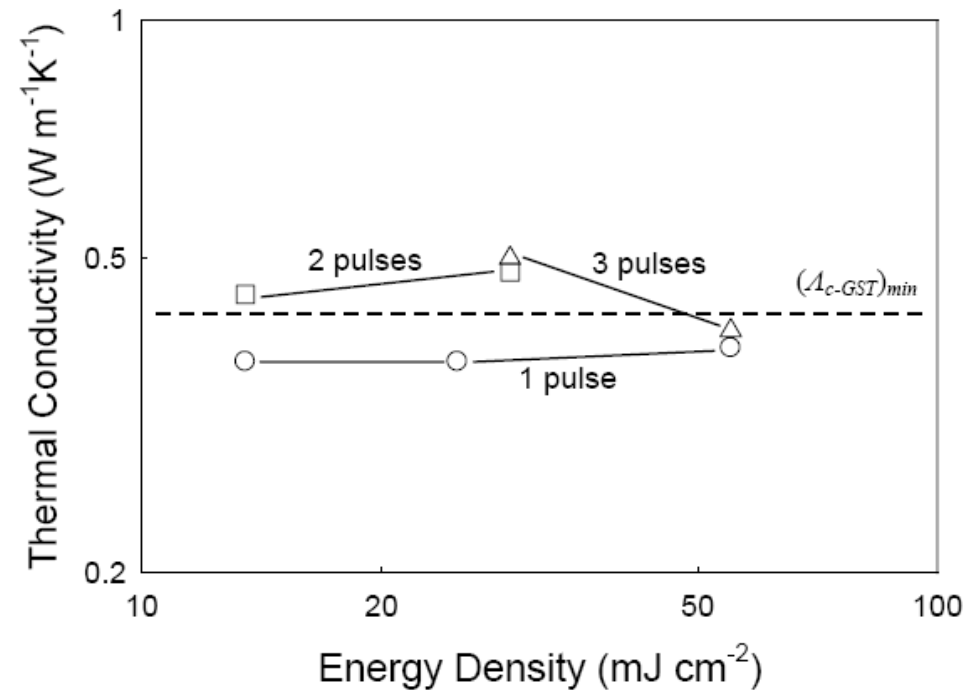
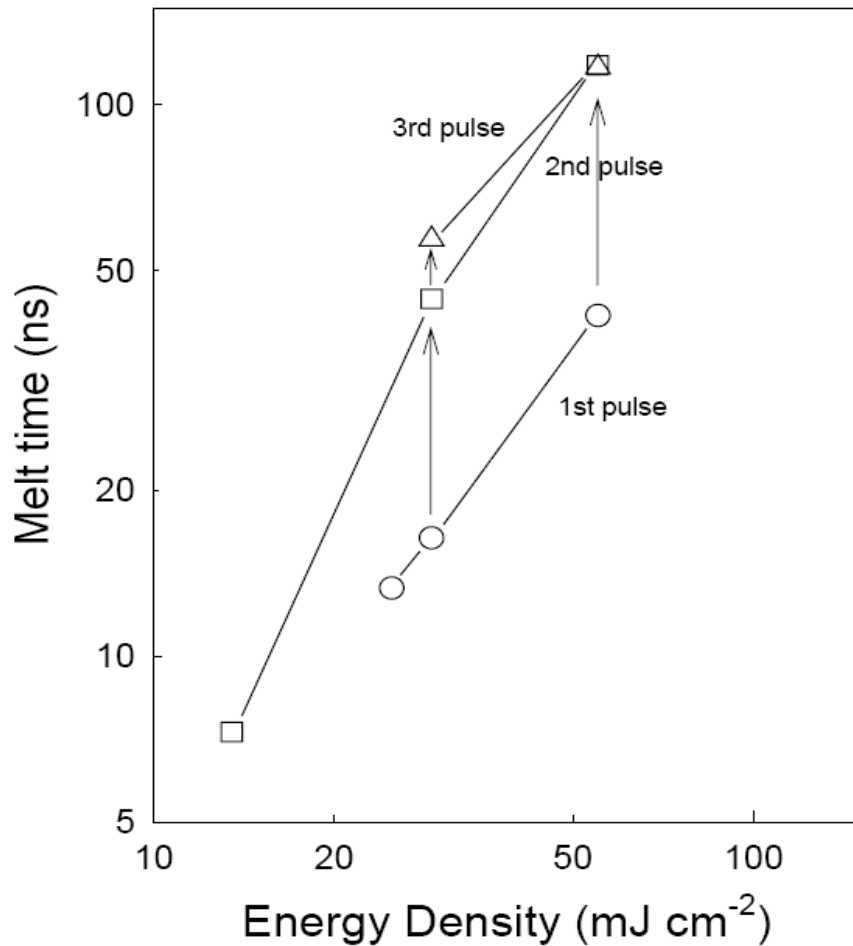
Ge₂Sb₂Te₅ during temperature ramp

- Low conductivity in the cubic-phase (comparable to predicted Λ_{\min}) increases modestly with annealing.



Cubic $\text{Ge}_2\text{Sb}_2\text{Te}_5$ formed by nsec laser pulse

- 523 nm, Q-switched doubled-YAG laser



Minimum thermal conductivity

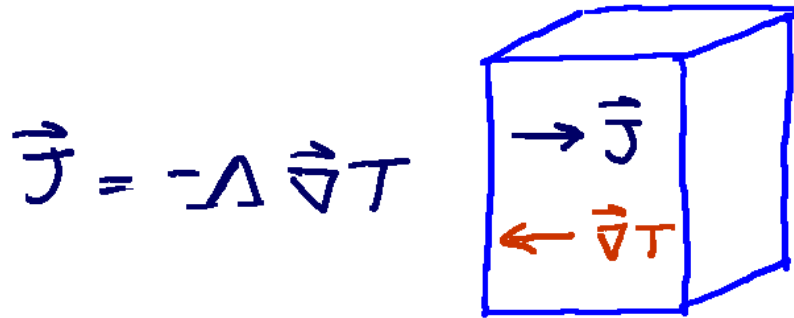
- Both amorphous and “early” cubic phase have thermal conductivities comparable to the predicted minimum conductivity based on atomic density n and speeds of sound v .

High T limit $\Lambda_{\min} = \frac{1}{2} \left(\frac{\pi}{6} \right)^{1/3} k_B n^{2/3} (v_l + 2v_t)$

- v_l measured directly by picosecond acoustics
- Assume $v_t = 0.6 v_l$

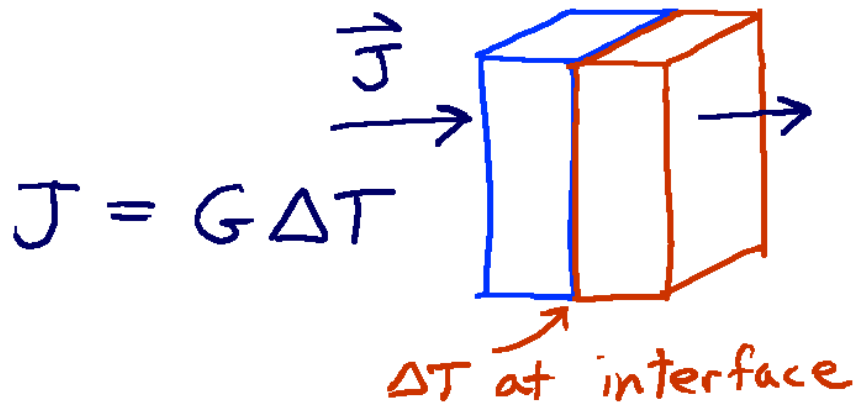
Thermal conductivity and interface thermal conductance

- Thermal conductivity Λ is a property of the continuum



$$\Lambda = \frac{1}{3Vk_B T^2} \int_0^\infty \langle \vec{j}(t) \cdot \vec{j}(0) \rangle dt$$

- Thermal conductance (per unit area) G is a property of an interface



$$G = \frac{1}{Ak_B T^2} \int_0^\infty \langle q(t)q(0) \rangle dt$$

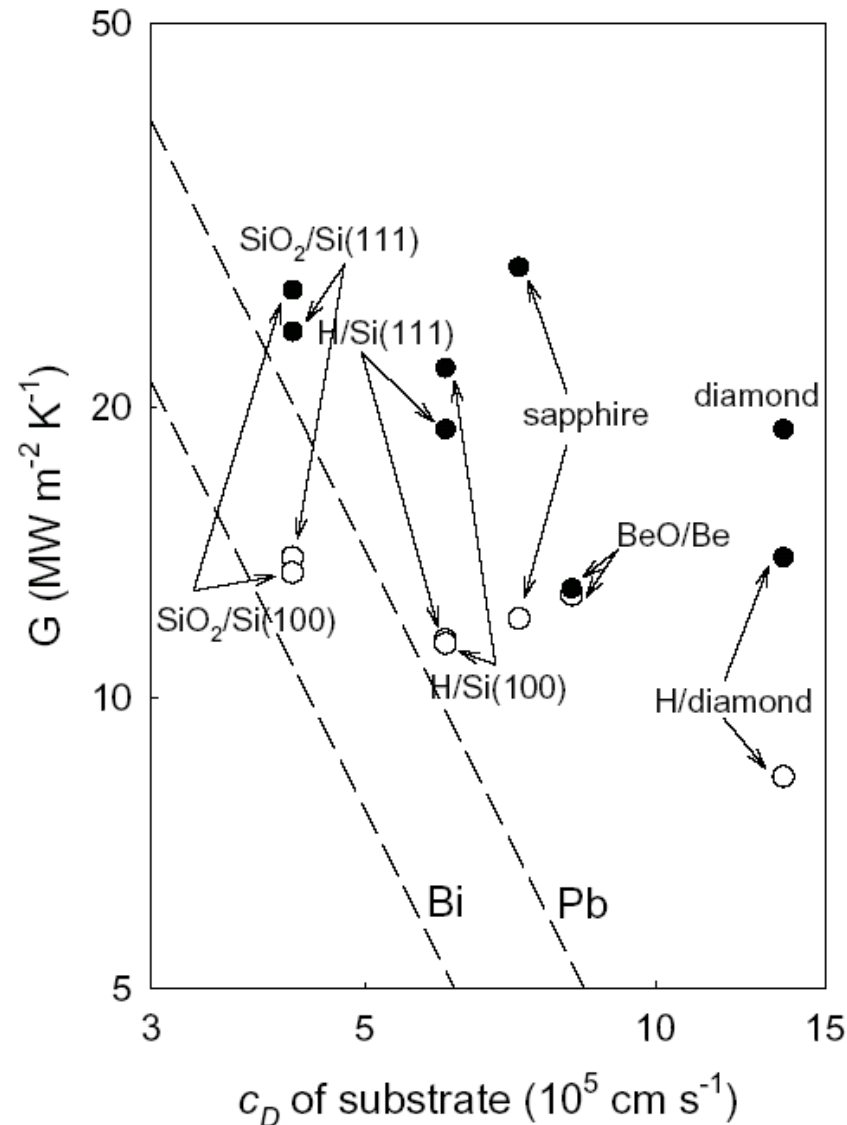
Interface thermal conductance between GST and electrodes

- Difficult to measure because thermal conductivities are small and, for c-GST, depends on thickness; see Reifenberg et al. (2007) and Lee et al. (2000).
- And hard to predict because analytical models do not include anharmonicity or details of the interface structure and bonding.
- high temperature limit of the *radiation limit*

$$G = \frac{\pi}{3} \frac{k_b v_{\max}^3}{v_D^2}$$

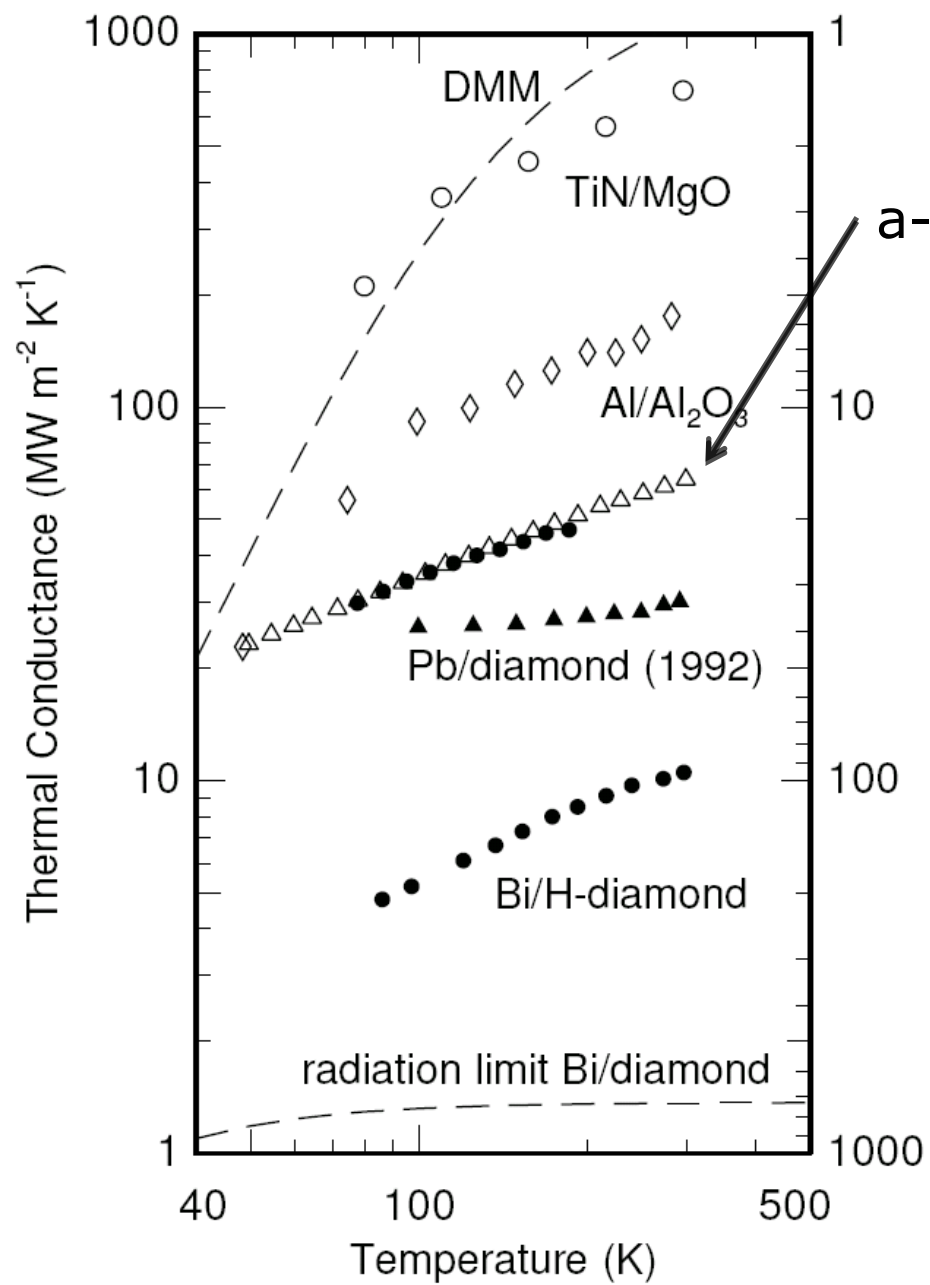
v_{\max} : vibrational cutoff frequency of material A
($v_{\max} = 1.8$ THz for Bi, 2.23 THz for Pb)
 v_D : Debye velocity of material B

Room temperature thermal conductance



- Pb and Bi show similar behavior. Electron-phonon coupling is not an important channel.
- Weak dependence on Debye velocity of the substrate.
- For Pb and Bi, conductance always larger than predicted by a purely elastic process.

Interface thermal conductance: Factor of 60 range at room temperature



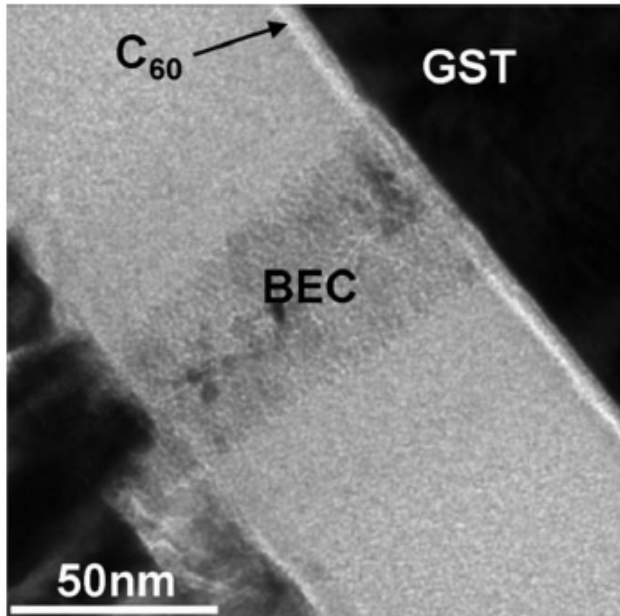
a-GST/ZnS:SiO₂ Lee et al. (2000)

$$L = \Lambda / G$$
$$\Lambda = 1 \text{ W m}^{-1} \text{ K}^{-1}$$

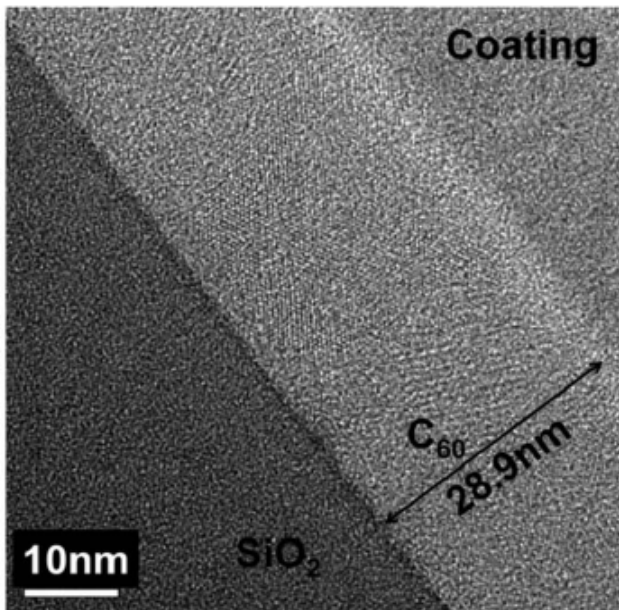
Bottom line...

- Thermal conductance of $\text{Ge}_2\text{Sb}_2\text{Te}_5$ /nitride interfaces is not known precisely. Limited data and analogy to Pb interfaces suggests $G \approx 25 \text{ MW m}^{-2} \text{ K}^{-1}$ at room temperature.
- Kapitza length $L = \Lambda/G \approx 10 \text{ nm}$ for a- $\text{Ge}_2\text{Sb}_2\text{Te}_5$
- Not yet measured but G will probably increase significantly with temperature.
- For liquid (metallic) $\text{Ge}_2\text{Sb}_2\text{Te}_5$, conductance will become large because of electronic thermal transport.

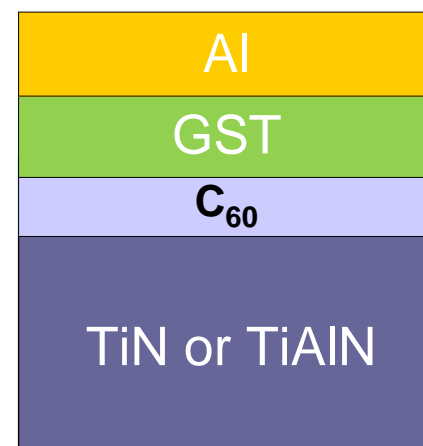
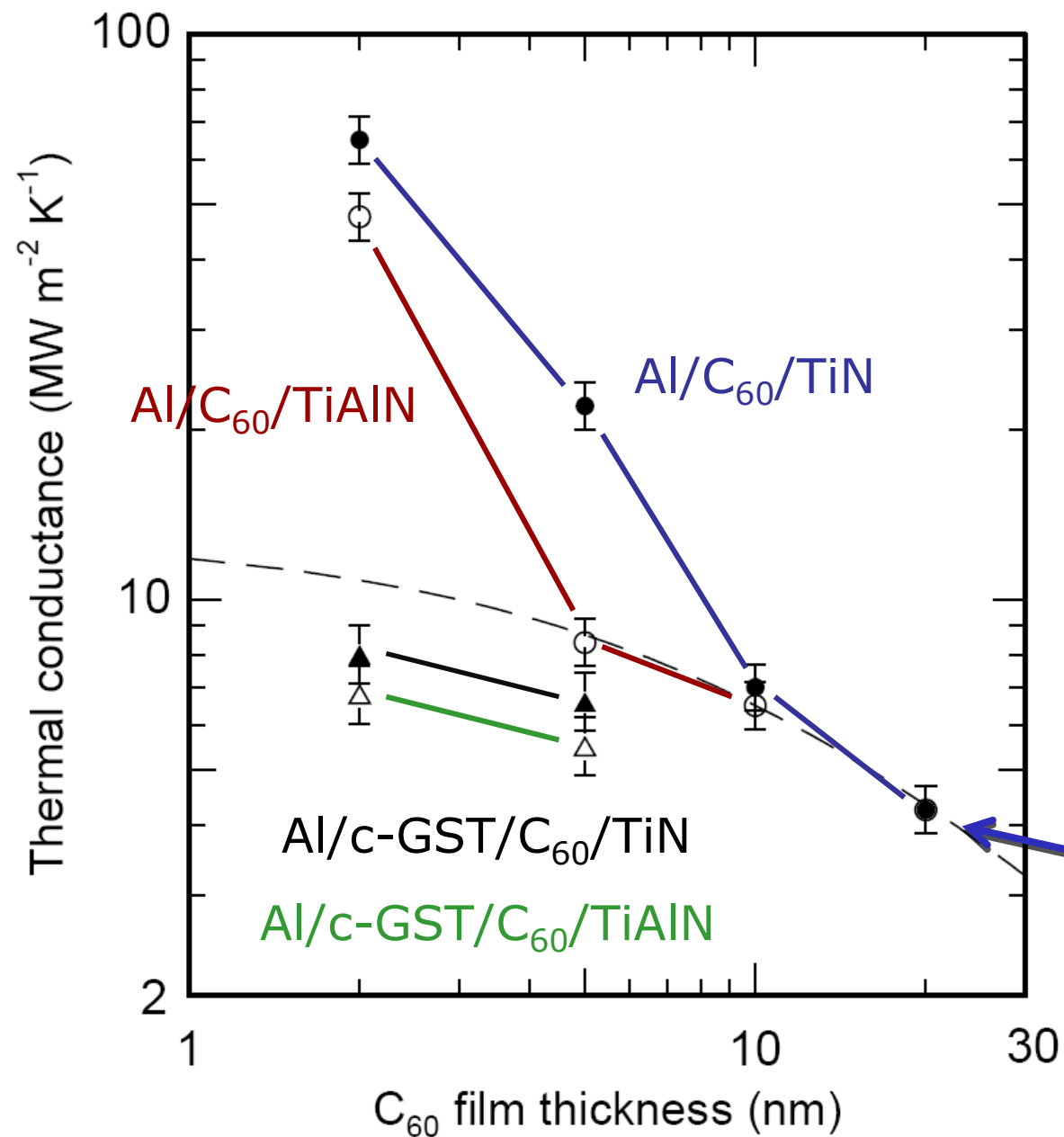
C_{60} fullerene as thermal insulation



- Evaporate C_{60} on TiN or TiAlN back-electrode contacts
- Add $Ge_2Sb_2Te_5$ layer (or not)
- Coat with Al for thermal transport measurements by time-domain thermoreflectance



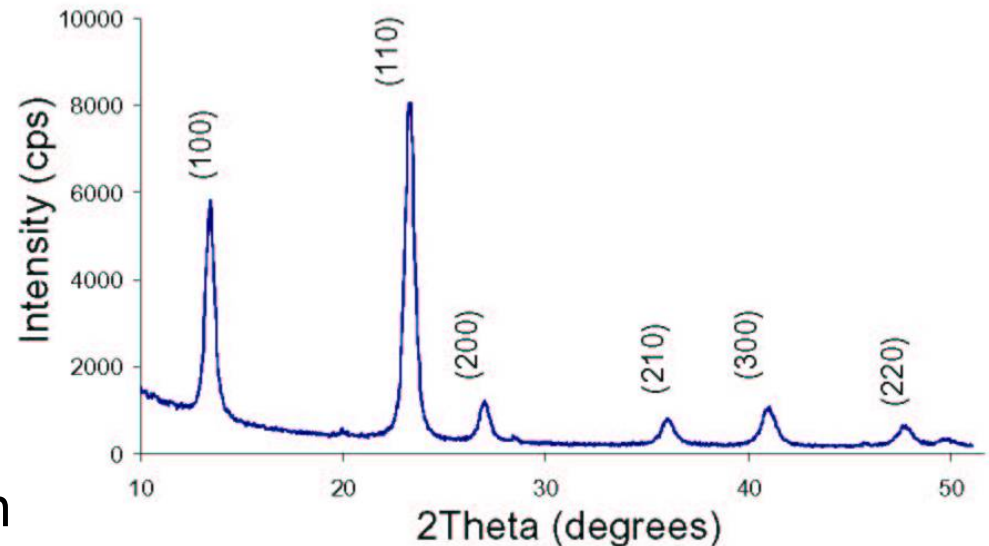
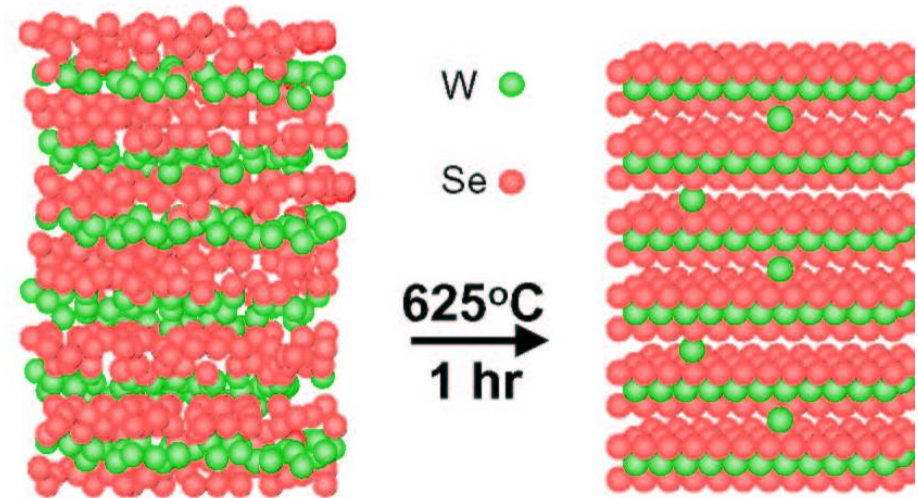
C₆₀ fullerene as thermal insulation



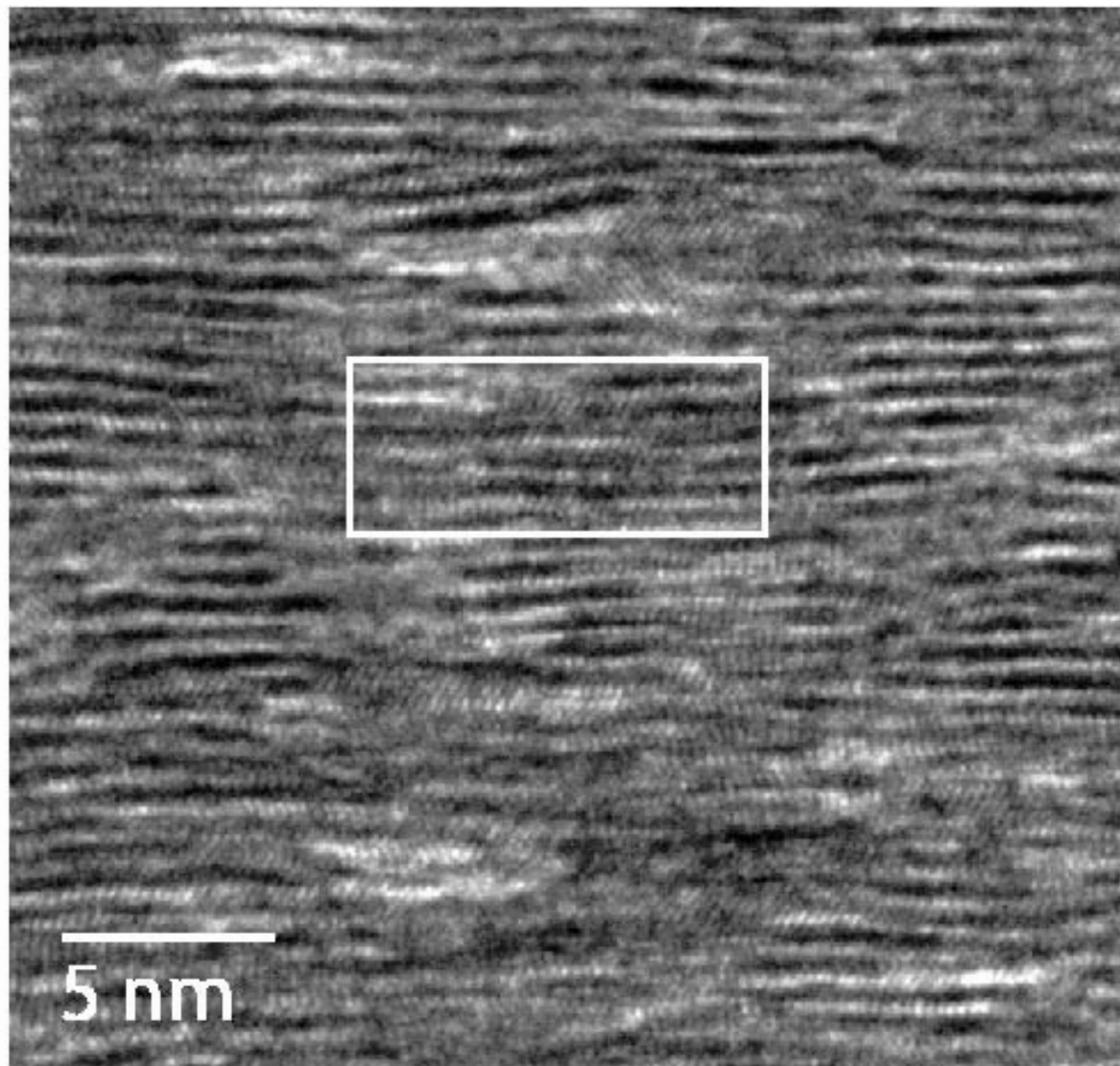
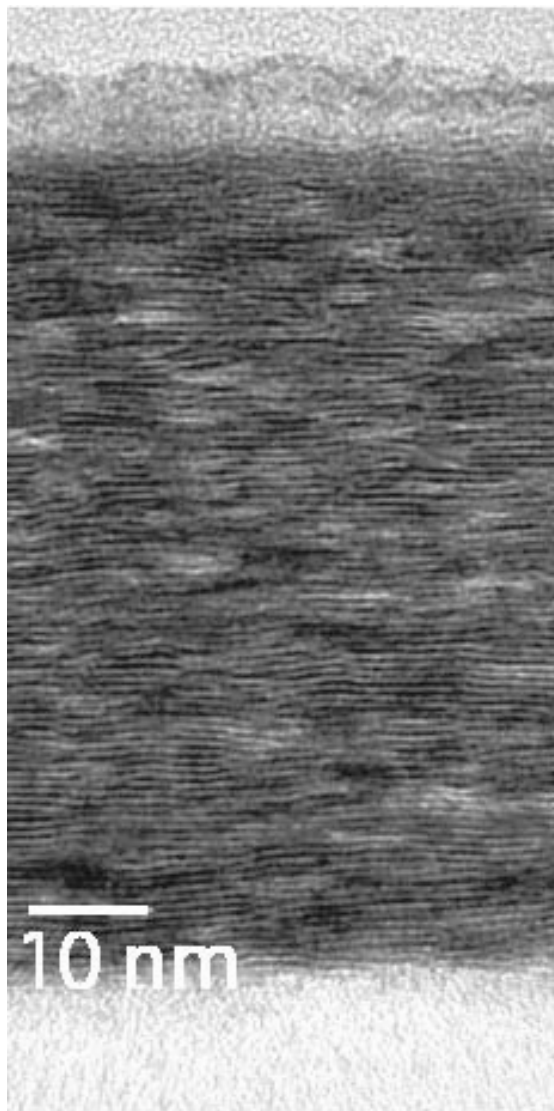
Fit gives interface conductance and conductivity of C₆₀
 $G = 13 \text{ MW m}^{-2} \text{ K}^{-1}$
 $\Lambda = 0.13 \text{ W m}^{-1} \text{ K}^{-1}$

Layered disordered crystals: WSe_2 by “modulated elemental reactants”

- Deposit W and Se layers at room temperature on Si substrates
- Anneal to remove excess Se and improve crystallinity
- Characterize by RBS, x-ray diffraction (lab sources and Advanced Photon Source) and TEM



Cross-sectional TEM of 60 nm thick WSe_2

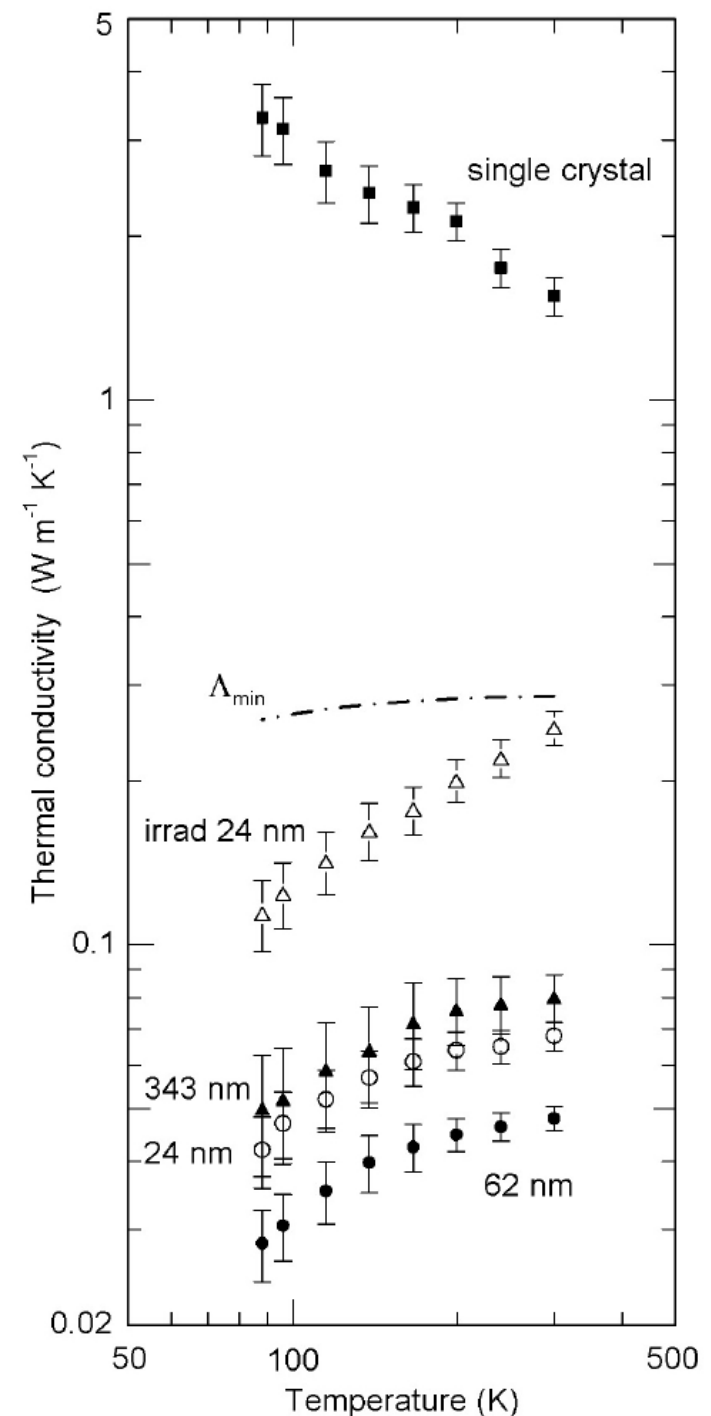


Seongwon Kim and Jian Min Zuo

Thermal conductivity of WSe_2

- 60 nm film has the lowest thermal conductivity ever observed in a fully dense solid. Only twice the thermal conductivity of air.
- A factor of 6 less than the calculated amorphous limit for this material.

Chiritescu et al. Science (2006)



Conclusions

- Thermal conductivity of amorphous and “early” cubic phase and laser crystallized cubic phase are all comparable to the predicted minimum thermal conductivity → strong disorder in the crystal
- Thermal conductance of interfaces with nitride electrodes is equivalent to ≈ 10 nm thick layer of amorphous GST, decreases with thickness.
- C_{60} layer provides thermal resistance equivalent to ≈ 20 nm thick layer of amorphous GST
- Could, in principle produce the same thermal resistance with a 5 nm thick layer of a *disordered layered crystal* such as WSe_2 .